

Silicon Carbide Power MOSFET E-Series Automotive N-Channel Enhancement Mode

Features

- E4M generation SiC MOSFET technology
- Optimized package with separate driver source pin
- 8mm of creepage distance between drain and source
- High blocking voltage with low on-resistance
- · High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Q,,)
- Halogen free, RoHS compliant
- Automotive Qualified (AEC-Q101) and PPAP Capable

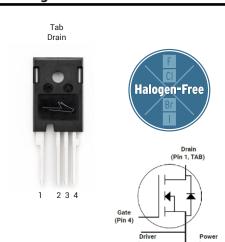
Benefits

- · Reduce switching losses and minimize gate ringing
- · Higher system efficiency
- · Reduce cooling requirements
- Increase power density
- Increase system switching frequency

Applications

- Motor Control
- EV Battery Chargers
- High Voltage DC/DC Converters

Package





RoHS
KUHS

Part Number	Package	Marking
E4M0013120K	TO-247-4L	E4M0013120K

Maximum Ratings (T_c = 25 °C unless otherwise specified)

Symbol	Parameter	Value	Unit	Note	
V_{DSmax}	Drain - Source Voltage		1200	V	
V_{GSmax}	Gate - Source Voltage		-8/+19	٧	Note: 1
		T _C = 25°C	153	Α	Fig. 19
I _D	Continuous Drain Current, V _{GS} = 15 V		107		Note: 2
I _{D(pulse)}	Pulsed Drain Current, Pulse width t _P limited by T _{jmax}	337	А	Fig. 22	
$P_{\scriptscriptstyle D}$	Power Dissipation, $T_c = 25^{\circ}C$, $T_J = 175^{\circ}C$	517	W	Fig. 20 Note: 2	
T_{J} , T_{stg}	Operating Junction and Storage Temperature	-55 to +175	°C		
T_{L}	Solder Temperature, 1.6mm (0.063") from case for 10s	260	°C		
M_{d}	Mounting Torque , M3 or 6-32 screw	1 8.8	Nm lbf-in		

Note (1): Recommended turn off / turn on gate voltage $V_{\rm GS}$ - 4V...0V / +15V

Note (2): Verified by design

Electrical Characteristics (T_c = 25°C unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	Note
V _{(BR)DSS}	Drain-Source Breakdown Voltage	1200			V	$V_{GS} = 0 \text{ V, } I_D = 100 \mu\text{A}$	
V _{GS(th)}	Gate Threshold Voltage	1.8	2.5	3.8	V	V _{DS} = V _{GS} , I _D = 23.18 mA	Fig 11
V GS(th)	oute Threshold Tollage		2.0		V	$V_{DS} = V_{GS}$, $I_D = 23.18$ mA, $T_J = 175$ °C	Fig. 11
I _{DSS}	Zero Gate Voltage Drain Current		1	50	μΑ	V _{DS} = 1200 V, V _{GS} = 0 V	
I _{GSS}	Gate-Source Leakage Current		10	250	nA	V _{GS} = 15 V, V _{DS} = 0 V	
R _{DS(on)}	Drain-Source On-State Resistance		13	17	mΩ	V _{GS} = 15 V, I _D = 84.29 A	Fig. 4,
US(on)			23			V _{GS} = 15 V, I _D = 84.29 A, T _J = 175°C	5, 6
g _{fs}	Transconductance		62		S	V _{DS} = 20 V, I _{DS} = 84.29 A	Fig. 7
915			58			V _{DS} = 20 V, I _{DS} = 84.29 A, T _J = 175°C	9
C _{iss}	Input Capacitance		7407]		
Coss	Output Capacitance		202		pF	$V_{GS} = 0 \text{ V}, V_{DS} = 0 \text{V to } 1000 \text{ V}$	Fig. 17, 18
C _{rss}	Reverse Transfer Capacitance		21]	F = 100 kHz VAC = 25 mV	
E _{oss}	C _{oss} Stored Energy		130		μJ	VAC = 25 IIIV	Fig. 16
C _{o(er)}	Effective Output Capacitance (Energy Related)		288		pF	V 0VV 0 000V	Ī.,
C _{o(tr)}	Effective Output Capacitance (Time Related)		458		pF	V _{GS} = 0 V, V _{DS} = 0 800V	Note: 3
Eon	Turn-On Switching Energy (External Diode)		1724			V_{DS} = 800 V, V_{GS} = -4 V/15 V, I_{D} = 84.29 A,	Fig. 26,
E _{OFF}	Turn Off Switching Energy (External Diode)		2687		μJ	$R_{G(ext)}$ = 2.5 Ω, L= 99 μH, T_J = 175°C FWD = External SiC DIODE	28
Eon	Turn-On Switching Energy (Body Diode FWD)		2937			V _{DS} = 800 V, V _{GS} = -4 V/15 V, I _D = 84.29 A,	Fig. 26,
E _{OFF}	Turn-Off Switching Energy (Body Diode FWD)		2637		μJ	$R_{G(ext)}$ = 2.5 Ω, L= 99 μH, T_J = 175°C FWD = Internal Body Diode	28
t _{d(on)}	Turn-On Delay Time		12				
t _r	Rise Time		67			V_{DD} = 800 V, V_{GS} = -4 V/15 V I_{D} = 84.29 A, $R_{G(ext)}$ = 2.5 Ω ,	Fig. 27,
t _{d(off)}	Turn-Off Delay Time		166		ns	Timing relative to V _{DS}	28
t _f	Fall Time		37			- Inductive foud	
R _{G(int)}	Internal Gate Resistance		7.8		Ω	f = 1 MHz, V _{AC} = 25 mV	
Q_{gs}	Gate to Source Charge		76			V _{DS} = 800 V, V _{GS} = -4 V/15 V	
Q_{gd}	Gate to Drain Charge		102		nC	I _D = 84.29 A	Fig. 12
Q_g	Total Gate Charge		293		Per IEC60747-8-4 pg 21		

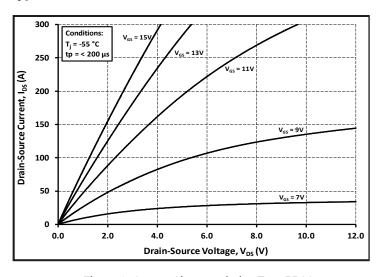
Note (3): $C_{\circ(er)}$, a lumped capacitance that gives same stored energy as Coss while Vds is rising from 0 to 800V $C_{\circ(tr)}$, a lumped capacitance that gives same charging time as Coss while Vds is rising from 0 to 800V

Reverse Diode Characteristics ($T_c = 25^{\circ}C$ unless otherwise specified)

Symbol	Parameter	Тур.	Max.	Unit	Test Conditions	Note
V	Diode Forward Voltage	5.1		٧	V _{GS} = -4 V, I _{SD} = 42.15 A, T _J = 25 °C	Fig. 8,
V _{SD}		4.7		V	V _{GS} = -4 V, I _{SD} = 42.15 A, T _J = 175 °C	9,10
Is	Continuous Diode Forward Current		89	Α	V _{GS} = -4 V, T _C = 25°C	
I _{S, pulse}	Diode pulse Current		337	Α	$V_{GS} = -4 \text{ V}$, pulse width t_P limited by T_{jmax}	
t _{rr}	Reverse Recover time	67		ns		
Q _{rr}	Reverse Recovery Charge	1594		nC	$V_{SS} = -4 \text{ V, I}_{SD} = 84.29 \text{ A, V}_{R} = 800 \text{ V}$ dif/dt = 2270 A/µs, T, = 175 °C	
I _{rrm}	Peak Reverse Recovery Current	41		А		
t _{rr}	Reverse Recover time	122		ns		
Q _{rr}	Reverse Recovery Charge	1496		nC	V _{GS} = -4 V, I _{SD} = 84.29 A, V _R = 800 V dif/dt = 1270 A/μs, T ₋ = 175 °C	
l _{rrm}	Peak Reverse Recovery Current	30		А	α, α 12.0 7 γ μος 1, 110 0	

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit	Test Conditions	Note
$R_{ heta JC}$	Thermal Resistance from Junction to Case	0.22	0.29	°C/W		Fig. 21



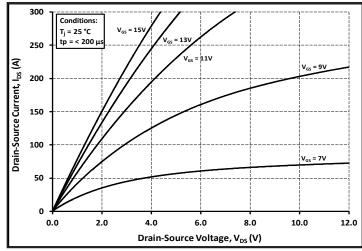
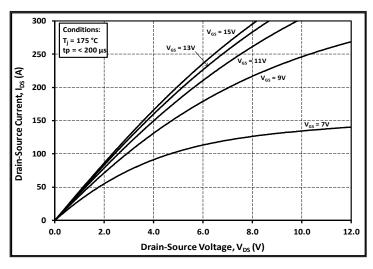


Figure 1. Output Characteristics T_J = -55 °C





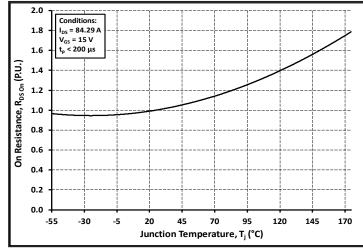
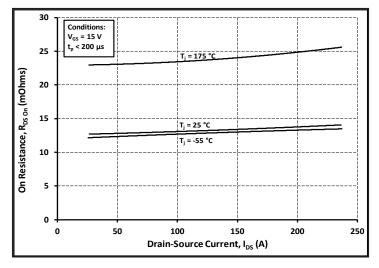


Figure 3. Output Characteristics T_J = 175 °C

Figure 4. Normalized On-Resistance vs. Temperature



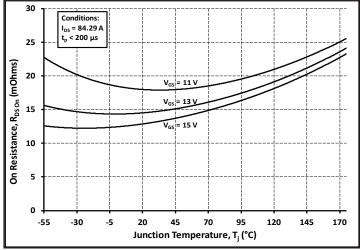


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

Figure 6. On-Resistance vs. Temperature For Various Gate Voltage

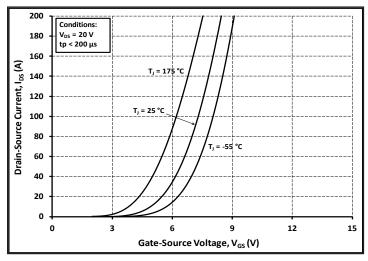


Figure 7. Transfer Characteristic for Various Junction Temperatures

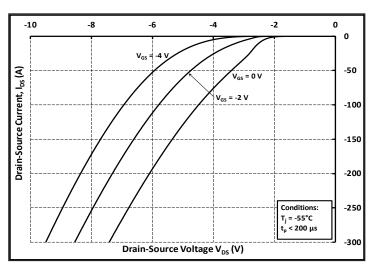


Figure 8. Body Diode Characteristic at -55 °C

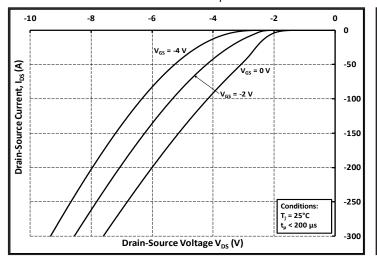


Figure 9. Body Diode Characteristic at 25 °C

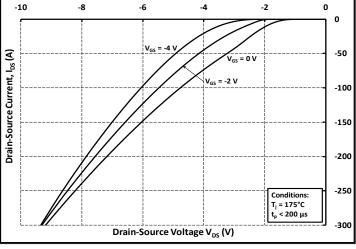


Figure 10. Body Diode Characteristic at 175 °C

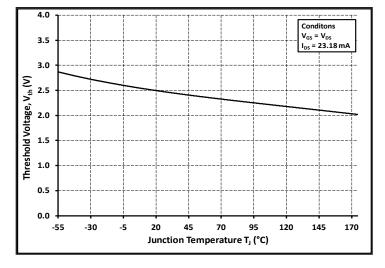


Figure 11. Threshold Voltage vs. Temperature

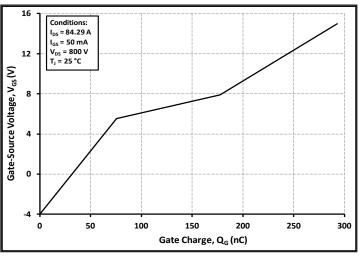
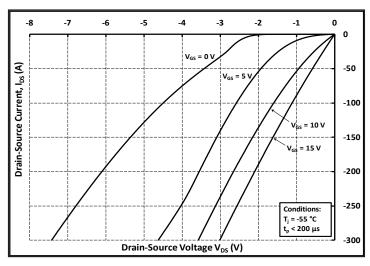


Figure 12. Gate Charge Characteristics





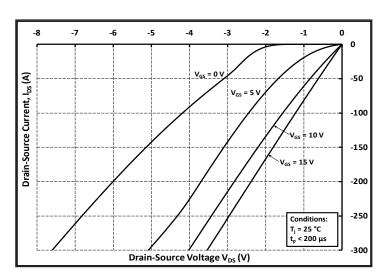


Figure 14. 3rd Quadrant Characteristic at 25 °C

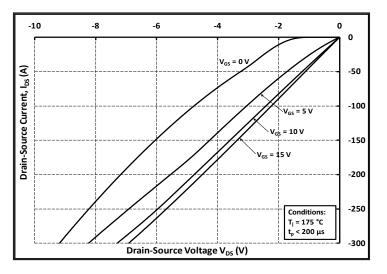


Figure 15. 3rd Quadrant Characteristic at 175 °C

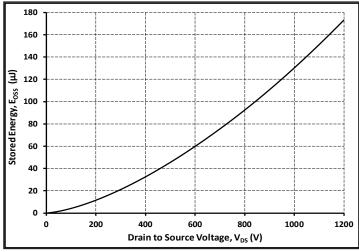


Figure 16. Output Capacitor Stored Energy

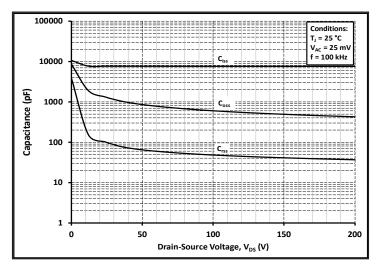


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

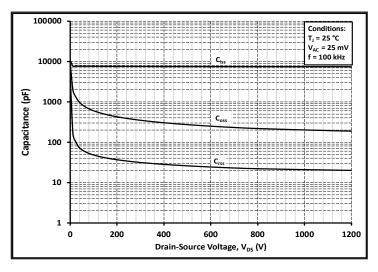


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1200V)

600

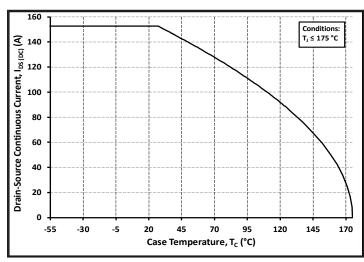
500

400

300

200

Typical Performance

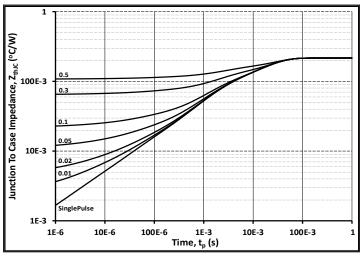


Maximum Dissipated Power, P_{tot} (W) 100 -30 -5 70 -55 20 45 95 120 145 Case Temperature, T_C (°C)

Figure 19. Continuous Drain Current Derating vs. Case Temperature

Figure 20. Maximum Power Dissipation Derating vs. Case Temperature

Conditions T_J ≤ 175 °C



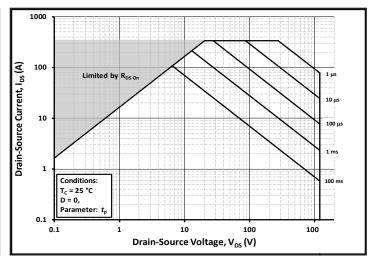
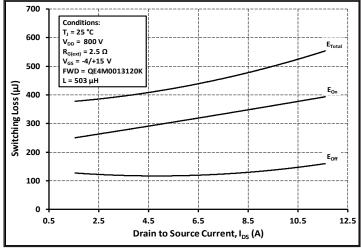


Figure 21. Transient Thermal Impedance (Junction - Case)

Figure 22. Safe Operating Area



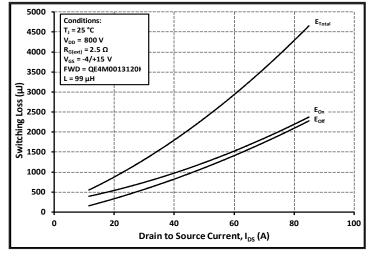


Figure 23. Clamped Inductive Switching Energy vs. Low Drain Current (V_{DD} = 800V)

Figure 24. Clamped Inductive Switching Energy vs. High Drain Current ($V_{DD} = 800V$)

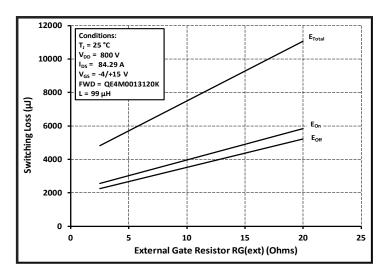


Figure 25. Clamped Inductive Switching Energy vs. $R_{G(ext)}$

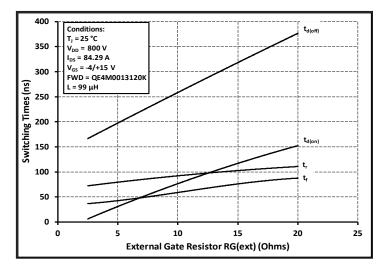


Figure 27. Switching Times vs. $R_{G(ext)}$

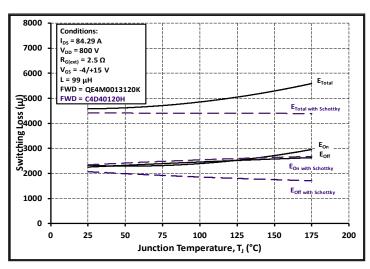


Figure 26. Clamped Inductive Switching Energy vs.
Temperature

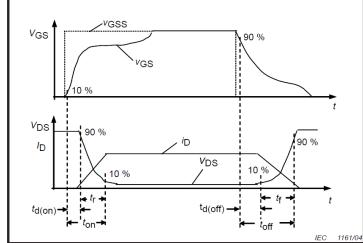


Figure 28. Switching Times Definition

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Test Circuit Schematic

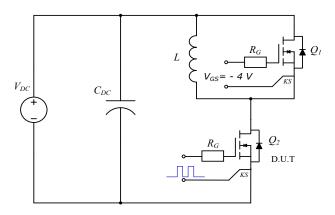
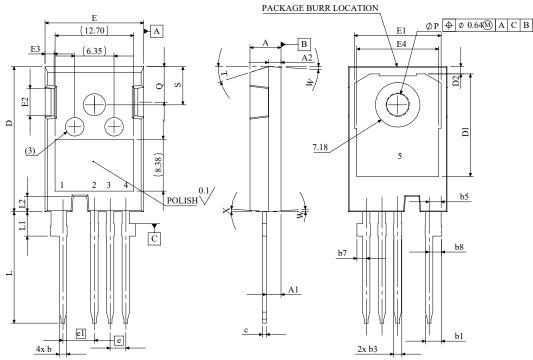


Figure 29. Clamped Inductive Switching Waveform Test Circuit

Package Dimensions



	0.25(M)	В	A(M)

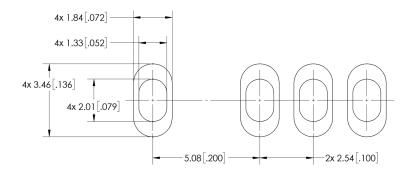
MIN (mm)	MAX (mm)	
4.83	5.21	
2.29	2.54	
1.91	2.16	
1.07	1.33	
2.39	2.94	
1.07	1.60	
2.39	2.69	
1.30	1.70	
1.80	2.20	
0.55	0.68	
23.30	23.60	
16.25	17.65	
0.95	1.25	
15.75	16.13	
13.1	14.15	
3.68	5.10	
1.00	1.90	
12.38	13.43	
2.54	4 BSC	
5.08	BSC	
17.31	17.82	
3.97	4.37	
2.35	2.65	
3.51	3.65	
5.49	6.00	
6.04	6.30	
17.5 ° REF.		
3.5° REF.		
4°	REF.	
	4.83 2.29 1.91 1.07 2.39 1.07 2.39 1.30 1.80 0.55 23.30 16.25 0.95 15.75 13.1 3.68 1.00 12.38 2.54 5.08 17.31 3.97 2.35 3.51 5.49 6.04 17.5 3.35	

1	DRAIN
2	SOURCE
3	DRIVER SOURCE
4	GATE
5	DRAIN

NOTE:

- ${\it 1. \ ALL\ METAL\ SURFACES\ ARE\ TIN\ PLATED\ (MATTE),} \\ {\it EXCEPT\ AREA\ OF\ CUT.}$
- 2. DIMENSIONING & TOLERANCING CONFORM TO ASME Y14.5M-1994.
- 3. ALL DIMENSIONS ARE LISTED IN MILLIMETERS. ANGLES ARE IN DEGREES.
- 4. BURR OR MOLD FLASH SIZE (0.5 mm) IS NOT INCLUDED IN THE DIMENSIONS

Recommended Solder Pad Layout



Revision history

Document Version	Date of release	Descriptiion of changes
1.0	January-2024	Initial datasheet

E4M0013120K 1.

Notes & Disclaimer

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